

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination NOSAKA, HITOSHI	
		Examiner	Art Unit	Page 1 of 1
		Michael Aboagye	1725	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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	N	JP 2002164379	07-2002	Japan	Makoto et al.	Ho1L 21/60
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